TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSIII)

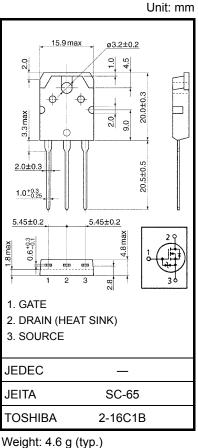
2SK2610

Chopper Regulator, DC–DC Converter and Motor Drive Applications

- Low drain-source ON resistance $: RDS (ON) = 2.3 \Omega (typ.)$
- High forward transfer admittance $|Y_{fs}| = 4.4 \text{ S (typ.)}$
- Low leakage current $: I_{DSS} = 100 \ \mu A \ (max) \ (V_{DS} = 720 \ V)$
- Enhancement mode $: V_{th} = 2.0 \sim 4.0 \text{ V} (V_{DS} = 10 \text{ V}, \text{ ID} = 1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		V _{DSS}	900	V
Drain-gate voltage (R _{GS} = 20 kΩ)		V _{DGR}	900	V
Gate-source voltage		V _{GSS}	±30	V
Drain current	DC (Note 1)	I _D	5	А
	Pulse (Note 1)	I _{DP}	15	A
Drain power dissipation	n (Tc = 25°C)	PD	150	W
Single pulse avalanche energy (Note 2)		E _{AS}	595	mJ
Avalanche current		I _{AR}	5	А
Repetitive avalanche energy (Note 3)		E _{AR}	15	mJ
Channel temperature		T _{ch}	150	°C
Storage temperature range		T _{stg}	-55~150	°C



vveignt: 4.6 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch−c)}	0.833	°C / W
Thermal resistance, channel to ambient	R _{th (ch−a)}	50	°C / W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: V_{DD} = 90 V, T_{ch} = 25°C (initial), L = 43.6 mH, I_{AR} = 5 A, R_G = 25 Ω

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.

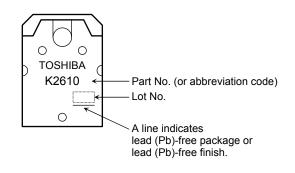
Electrical Characteristics (Ta = 25°C)

Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	irrent	I _{GSS}	V_{GS} = ±30 V, V_{DS} = 0 V	_	—	±10	μA
Gate-source bre	eakdown voltage	V (BR) GSS	I _G = ±10 μA, V _{DS} = 0 V	±30	_	_	V
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 720 V, V _{GS} = 0 V		_	100	μA
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	900	_	_	V
Gate threshold v	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	V
Drain-source O	N resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 3.0 A		2.3	2.5	Ω
Forward transfer	r admittance	Y _{fs}	V _{DS} = 20 V, I _D = 3.0 A	1.1	4.4	_	S
Input capacitance	e	C _{iss}		_	1200	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz	_	20	_	pF
Output capacitance		C _{oss}		_	120	_	
Switching time	Rise time	tr	$V_{GS} \stackrel{10V}{_{0V}} \prod_{\substack{D = 3A \\ OV}} V_{out}$ $R_{L} = 66.7\Omega$ $V_{DD} = 200V$	_	40	_	ns
	Turn-on time	t _{on}		_	90	_	
	Fall time	t _f		_	60	_	
	Turn-off time	t _{off}	Duty $\leq 1\%$, t _w =10µs	_	200	_	
Total gate charge (gate-source plus gate-drain)		Qg		_	45	_	
Gate-source charge		Q _{gs}	V _{DD} ≈ 400 V, V _{GS} = 10 V, I _D = 5 A		25		nC
Gate-drain ("miller") Charge		Q _{gd}			20	_	

Source–Drain Ratings and Characteristics (Ta = 25°C)

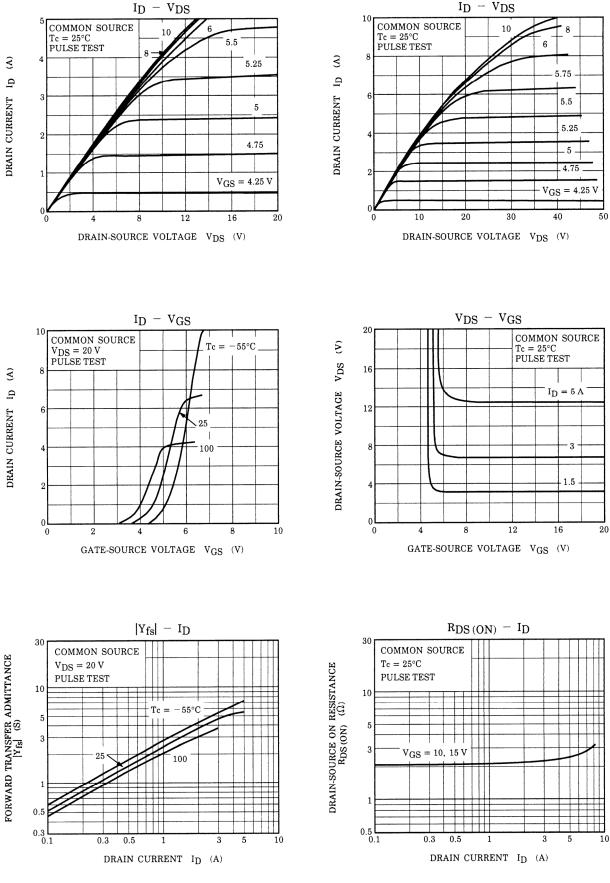
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—	_	_	5	А
Pulse drain reverse current (Note 1)	I _{DRP}	_	_		15	А
Forward voltage (diode)	V _{DSF}	I _{DR} = 5 A, V _{GS} = 0 V	_	-	-1.9	V
Reverse recovery time	t _{rr}	I _{DR} = 5 A, V _{GS} = 0 V, dI _{DR} / dt = 100 A / μs	_	1300		ns
Reverse recovery charge	Q _{rr}			11	_	μC

Marking

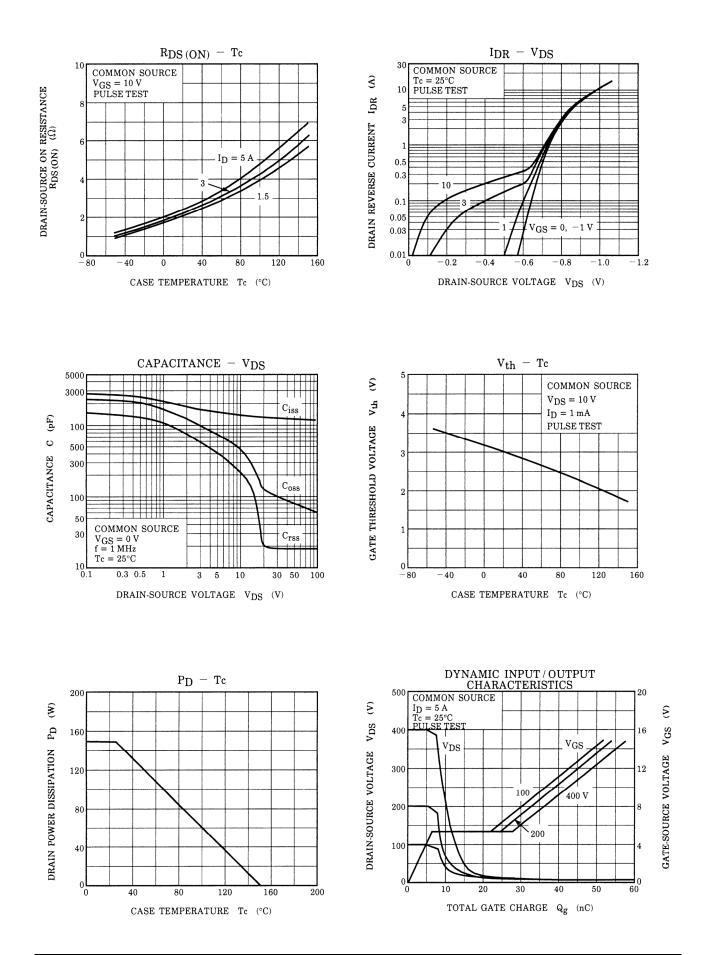


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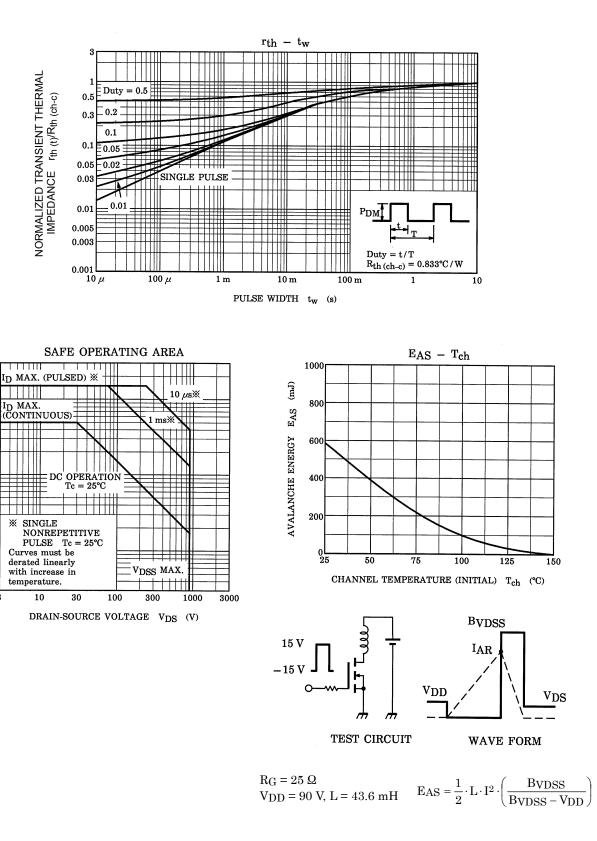
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DRAIN CURRENT ID



RESTRICTIONS ON PRODUCT USE

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